

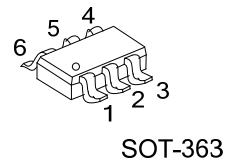
# 2N7002DW

**Power MOSFET**

**300m Amps, 60 Volts DUAL  
N-CHANNEL POWER MOSFET**

## ■ DESCRIPTION

The UTC **2N7002DW** has been designed to minimize on-state resistance to provide rugged, reliable, and fast switching performance. It can be used in most applications requiring up to 400mA DC and can deliver pulsed currents up to 2A. The product is particularly suited for low voltage, low current applications, such as small servo motor control, power MOSFET gate drivers and other switching applications

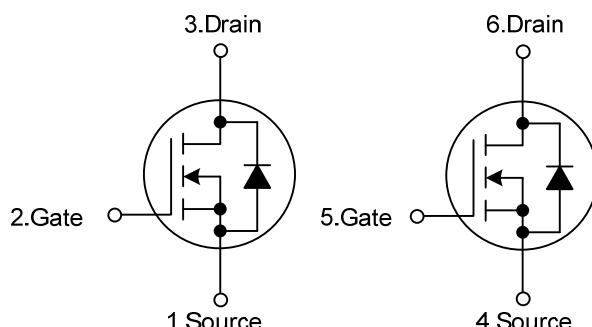


SOT-363

## ■ FEATURES

- \* High Density Cell Design for Low  $R_{DS(ON)}$ .
- \* Voltage Controlled Small Signal Switch
- \* Rugged and Reliable
- \* High Saturation Current Capability

## ■ SYMBOL

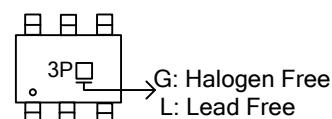


## ■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment						Packing
Lead Free	Halogen Free		1	2	3	4	5	6	
2N7002DWL-AL6-R	2N7002DWG-AL6-R	SOT-363	S1	G1	D2	S2	G2	D1	Tape Reel

2N7002DWG-AL6-R	(1)Packing Type (2)Package Type (3)Halogen Free	(1) R: Tape Reel (2) AL6: SOT-363 (3) G: Halogen Free, L: Lead Free
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## ■ MARKING



# 2N7002DW

Power MOSFET

## ■ ABSOLUTE MAXIMUM RATINGS (Ta=25°C unless otherwise noted.)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V <sub>DSS</sub>	60	V
Drain-Gate Voltage (R <sub>GS</sub> ≤ 1MΩ)		V <sub>DGR</sub>	60	V
Gate Source Voltage	Continuous	V <sub>GSS</sub>	±20	V
	Non Repetitive(tp<50μs)		±40	
Drain Current	Continuous	I <sub>D</sub>	300	mA
	Pulsed		800	
Power Dissipation Derated Above 25°C		P <sub>D</sub>	200 1.6	mW mW/°C
Junction Temperature	T <sub>J</sub>		+ 150	°C
Storage Temperature	T <sub>STG</sub>		-55 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

## ■ THERMAL CHARACTERISTICS

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ <sub>JA</sub>	625 (Note1)	°C/W

## ■ ELECTRICAL CHARACTERISTICS (T<sub>A</sub>=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFF CHARACTERISTICS</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =10μA	60			V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V			1	μA
Gate-Source Leakage Current	I <sub>GSSF</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V			100	nA
	I <sub>GSSR</sub>	V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V			-100	nA
<b>ON CHARACTERISTICS (Note 2)</b>						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =250μA	1	2.1	2.5	V
Drain-Source On-Voltage	V <sub>DS</sub> (ON)	V <sub>GS</sub> = 10V, I <sub>D</sub> =500mA		0.6	3.75	V
		V <sub>GS</sub> = 5.0V, I <sub>D</sub> =50mA		0.09	1.5	
On-State Drain Current	I <sub>D(ON)</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> ≥2V <sub>DS(ON)</sub>	500	2700		mA
Static Drain-Source On-Resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> =10V, I <sub>D</sub> =500mA, T <sub>J</sub> =125°C			13.5	Ω
		V <sub>GS</sub> =5.0V, I <sub>D</sub> =50mA			7.5	Ω
<b>DYNAMIC CHARACTERISTICS</b>						
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0MHz		20	50	pF
Output Capacitance	C <sub>OSS</sub>			11	25	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			4	5	pF
Turn-On Time	t <sub>ON</sub>	V <sub>DD</sub> =30V, R <sub>L</sub> =150Ω I <sub>D</sub> =200mA, V <sub>GS</sub> =10V R <sub>GEN</sub> =25Ω			20	nS
Turn-Off Time	t <sub>OFF</sub>	V <sub>DD</sub> =30V, R <sub>L</sub> =25Ω I <sub>D</sub> =200mA, V <sub>GS</sub> =10V R <sub>GEN</sub> =25Ω			20	nS
<b>DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS</b>						
Drain-Source Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =115mA (Note )		0.88	1.5	V
Maximum Pulsed Drain-Source Diode Forward Current	I <sub>SM</sub>				0.8	A
Maximum Continuous Drain-Source Diode Forward Current	I <sub>S</sub>				115	mA

Note: 1. Device mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch. Minimum land pad size.

2. Pulse Test: Pulse Width≤300μs, Duty Cycle≤2.0%



## ■ TEST CIRCUIT AND WAVEFORM

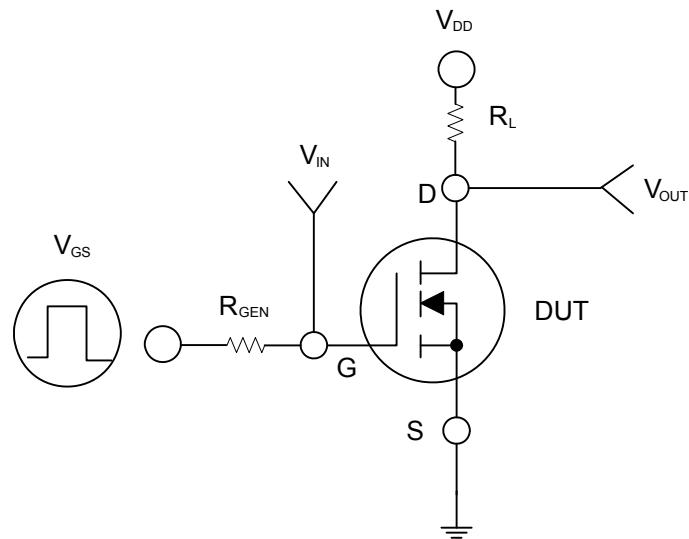


Figure 1

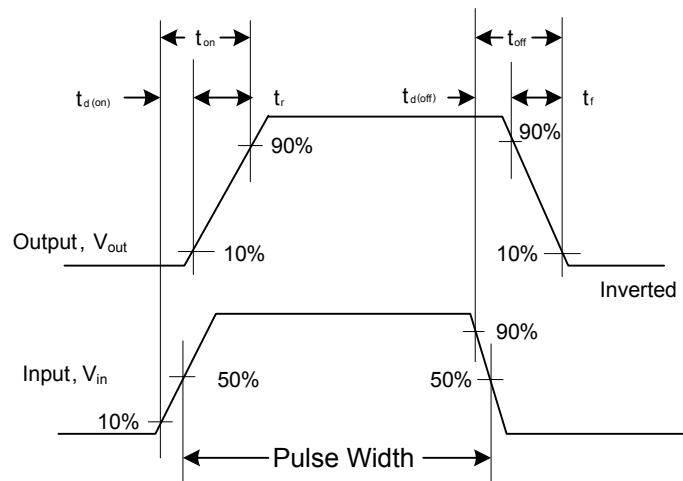
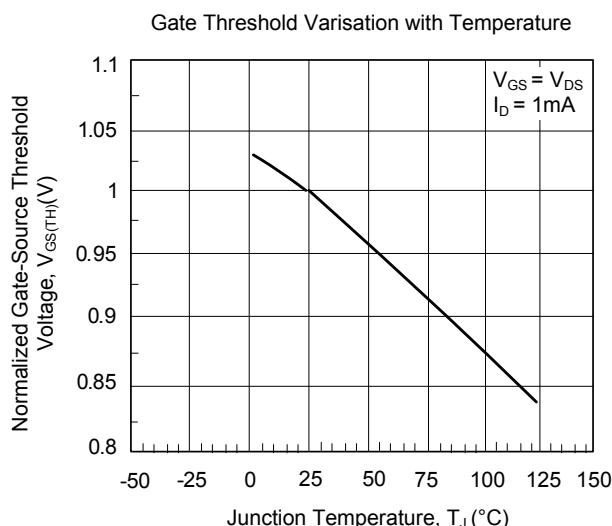
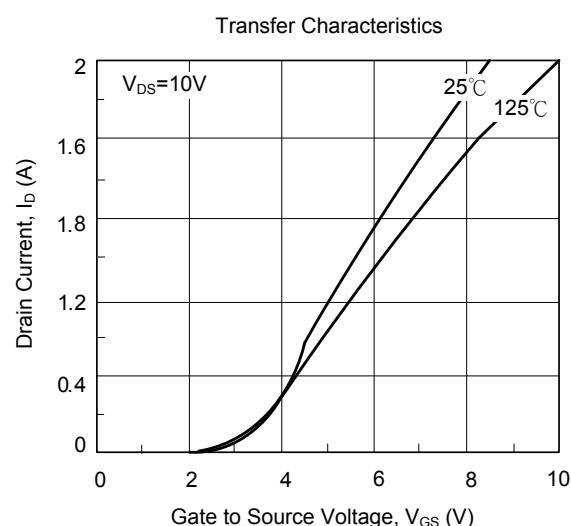
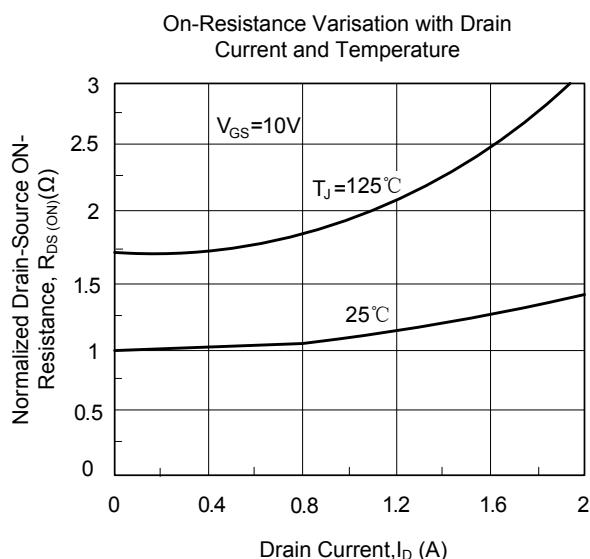
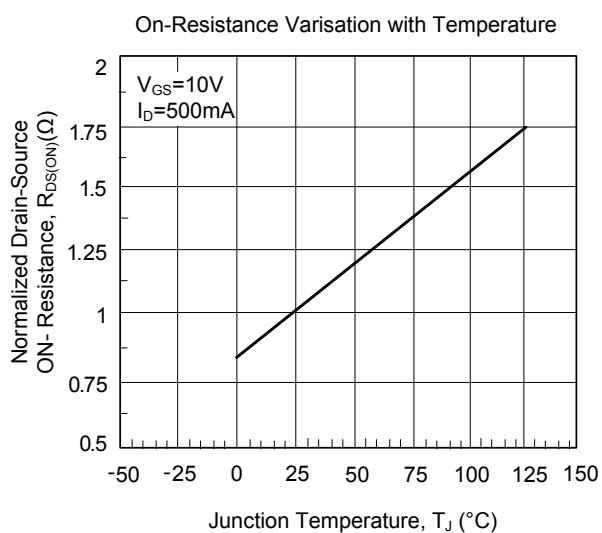
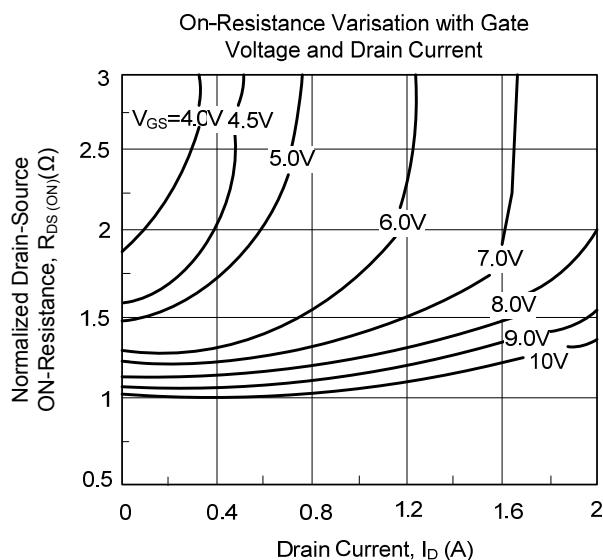
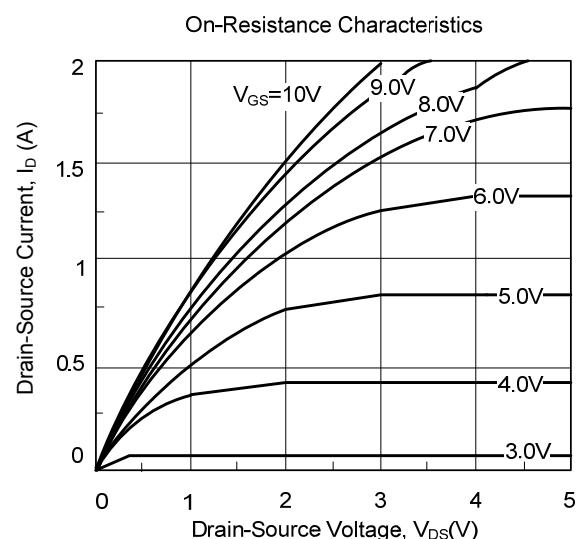
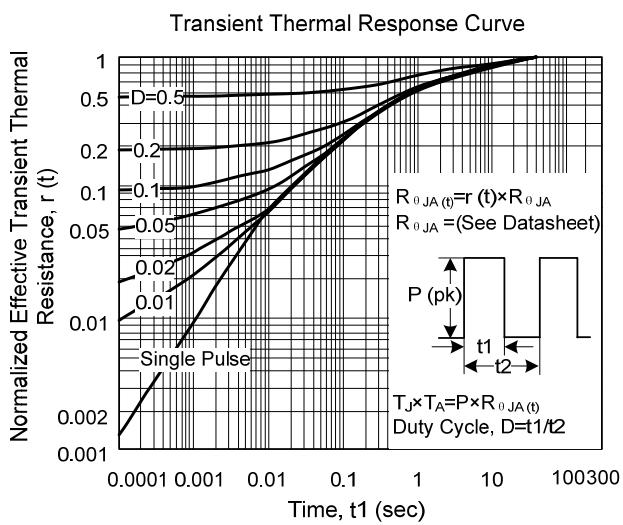
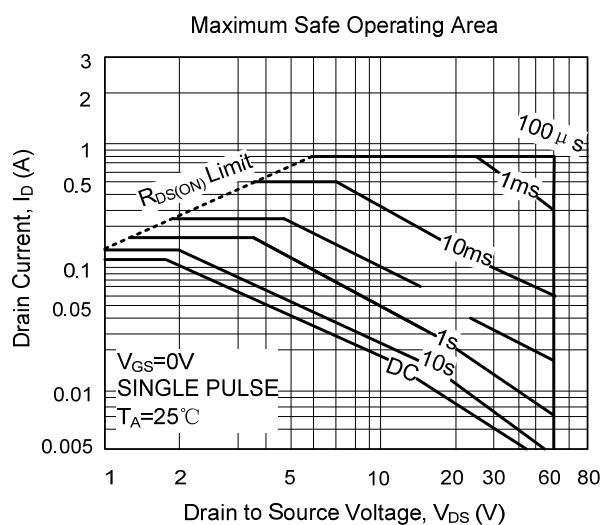
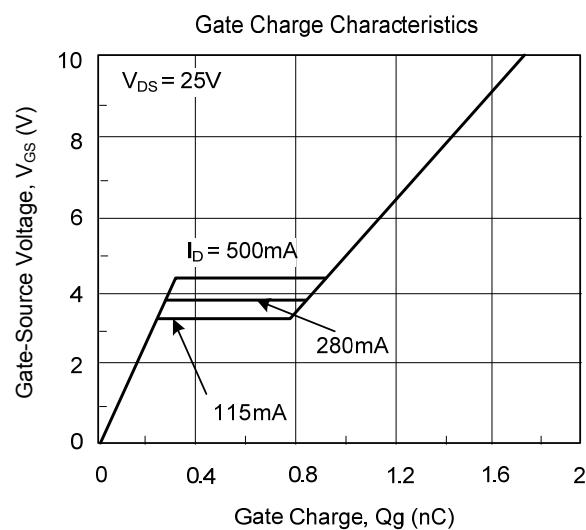
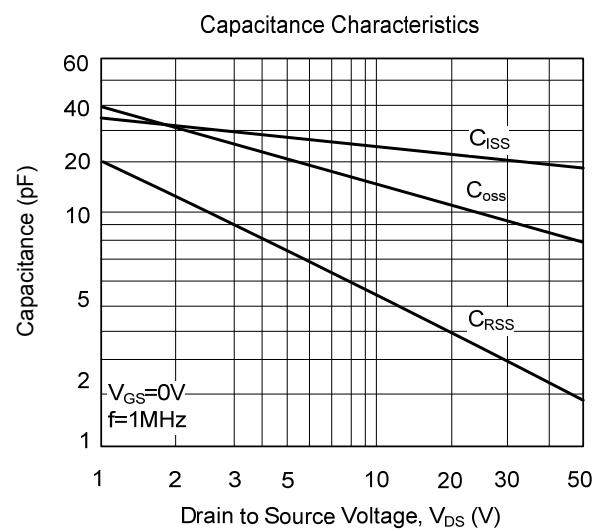
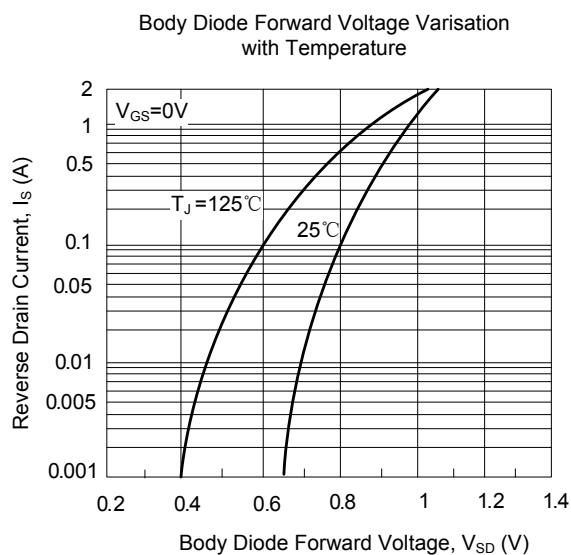
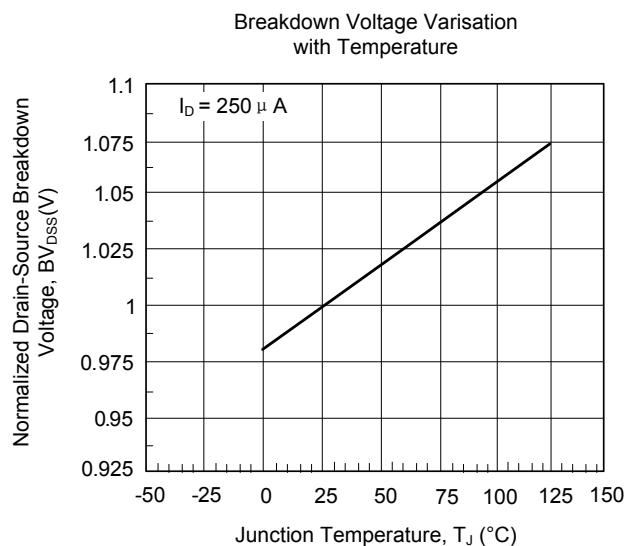


Figure 2. Switching Waveforms

■ TYPICAL CHARACTERISTICS



## ■ TYPICAL CHARACTERISTICS (Cont.)



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